

INFORMATION DISCLOSURE STATEMENT BY APPLICANT

Substitute for form 1449/PTO

Sheet 1 of 3
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Complete if Known
Application Number 09/776,550
Filing Date 02-02-01
First Named Inventor Zerbe, et al.
Group Art Unit ~~2174~~ 2863
Examiner Name Unknown
Attorney Docket Number 1726.7220800

U.S. PATENT DOCUMENTS

Examiner Initials *	Cite No. 1	U.S. Patent Document Number	Kind Code 2 (if known)	Name of Patentee or Applicant of Cited Document	Date of Publication of Cited Document MM-DD-YYYY	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
TL	AA	US2001/0016929	A1	Bonneau et al.	08-23-2001	
	AB	US2001/0021987	A1	Govindarajan et al.	09-13-2001	
	AC	US 5,917,856		Torsti	06-29-1999	
	AD	US 6,222,380	B1	Gerowitz et al.	04-24-2001	
	AE	US 6,289,045	B1	Hasegawa et al.	09-11-2001	
	AF	US 6,292,116	B1	Wang et al.	09-18-2001	
	AG					
	AH					
	AI					
	AJ					

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FOREIGN PATENT DOCUMENTS

Examiner Initials *	Cite No. 1	Foreign Patent Document Office 3	Number	Kind Code 2 (if known)	Name of Patentee or Applicant of Cited Document	Date of Publication of Cited Document MM-DD-YYYY	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear	T 6
TL	AK	EP	1 134 668	A2	Lucent Technologies	09-19-2001		<input type="checkbox"/>
	AL							<input type="checkbox"/>
	AM							<input type="checkbox"/>
	AN							<input type="checkbox"/>
	AO							<input type="checkbox"/>

PUBLICATIONS

Examiner Initials *	Cite No. 1	Title of Publication	Date of Publication of Cited Document MM-DD-YYYY
TL	AP	The Ouroboros of the Digital Consciousness...	01-04-1996
	AQ	Test High-Speed Drivers with Bursts...	05-12-1994
	AR	Use LFSRs to Build Fast FPGA-Based Counters	03-21-1994
	AS	Accurate On-Chip Interconnect Evaluation...	05-1999

Examiner Signature	<i>T. J. H. S.</i>	Date Considered	7-12-02
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*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

1 Unique citation designation number. 2 See attached Kinds of U.S. Patent Documents. 3 Enter Office that issued the document, by the two-letter code (WIPO Standard ST.3). 4 For Japanese patent documents, the indication of the year of the reign of the Emperor must precede the serial number of the patent document. 5 Kind of document by the appropriate symbols as indicated on the document under WIPO Standard ST. 16 if possible. 6 Applicant is to place a check mark here if English language Translation is attached.

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INFORMATION DISCLOSURE STATEMENT BY APPLICANT

Substitute for form 1449A/PTO

Complete if Known

Application Number 09/776,550

Filing Date 02-02-01

First Named Inventor Zerbe, et al.

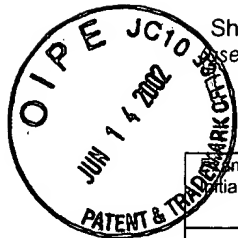
Group Art Unit 2474

Examiner Name Unknown

Attorney Docket Number 1726.7220800

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U.S. PATENT DOCUMENTS

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	AA					
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	AL						<input type="checkbox"/>
	AM						<input type="checkbox"/>
	AN						<input type="checkbox"/>
	AO						<input type="checkbox"/>

PUBLICATIONS

Examiner Initials *	Cite No. 1	Title of Publication	Date of Publication of Cited Document MM-DD-YYYY
2	AT	Multi-gigabit Signaling with CMOS	05-12-1997
	AU	HOTLink Built-In Self-Test (BIST)	03-11-1999
	AV	Accurate <i>In Situ</i> Measurement of Peak Noise and Delay Change...	10-2001
	AW	Characterization of Individual Weights in Transversal Filters...	12-1982

Examiner Signature	Date Considered
<i>Tym</i>	7-12-02

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Application Number 09/776,550

Filing Date 02-02-01

First Named Inventor Zerbe, et al.

Group Art Unit 2171

Examiner Name Unknown

Attorney Docket Number 1726.7220800

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U.S. PATENT DOCUMENTS

Examiner Initials *	Cite No. 1	U.S. Patent Document Number	Kind Code 2 (if known)	Name of Patentee or Applicant of Cited Document	Date of Publication of Cited Document MM-DD-YYYY	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
	AA					
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	AM							<input type="checkbox"/>
	AN							<input type="checkbox"/>
	AO							<input type="checkbox"/>

PUBLICATIONS

Examiner Initials *	Cite No. 1	Title of Publication	Date of Publication of Cited Document MM-DD-YYYY
TL	AX	Wide-Band Network Characterization by Fourier Transformation...	08-1969
I	AY	Modeling of High-Speed, Large-Signal Transistor Switching...	04-1982
	AZ		

Examiner Signature	<i>Tung</i>	Date Considered	7-12-02
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